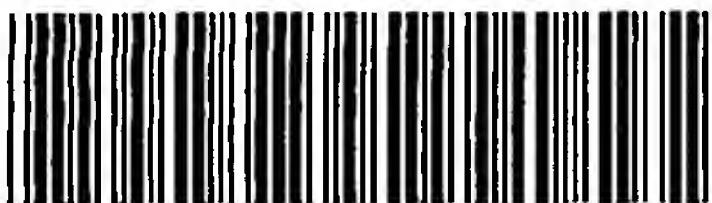


## **Search Notes**



**Application/Control No.**

**Applicant(s)/Patent under  
Reexamination**

10/710,860

GAN ET AL.

## Examiner

## Art Unit

R. Stephen Dildine

2112

**SEARCHED**

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                                                       | DATE      | EXMR |
|-------------------------------------------------------|-----------|------|
| US-PGPUB; USPAT; USOCR; EPO;<br>JPO; DERWENT; IBM_TDB | 2/9/2007  | RSD  |
| IEEEExplore                                           | 2/9/2007  | RSD  |
| Update all above                                      | 5/13/2007 | RSD  |
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| Inventors' Name search                                | 2/2/2007  | RSD  |

## INTERFERENCE SEARCHED

| <b>INTERFERENCE SEARCHED</b>             |                 |             |                 |
|------------------------------------------|-----------------|-------------|-----------------|
| <b>Class</b>                             | <b>Subclass</b> | <b>Date</b> | <b>Examiner</b> |
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| Text search, see Search History printout |                 | 5/13/2007   | RSD             |